杰力科技股份有限公司
Excelliance MOS Corporation

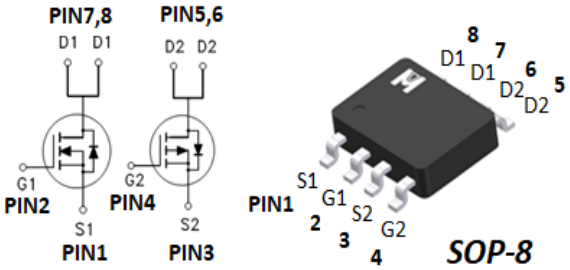
EMB18C03G

N-Channel + P Channel Logic Level Enhancement Mode Field Effect Transistor

▪Product Summary:

	N-CH	P-CH
BVDSS	30 V	-30 V
$R_{DSON\ (MAX.)}$@V_{GS}=10V	18 mΩ	22 mΩ
$R_{DSON\ (MAX.)}$@V_{GS}=4.5V	26 mΩ	37 mΩ
I_D @T_C=25°C	12 A	-12 A
I_D @T_A=25°C	8 A	-7 A

▪ Pin Description:



N Channel + P Channel MOSFET
UIS, Rg 100% Tested
Pb-Free Lead Plating & Halogen Free

▪ ABSOLUTE MAXIMUM RATINGS (T_A = 25 °C Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS		UNIT
			N-CH	P-CH	
Gate-Source Voltage		V_{GS}	±20	±20	V
Continuous Drain Current	T_C = 25 °C	I_D	12	-12	A
	T_C = 100 °C		8	-7	
Continuous Drain Current	T_A = 25 °C	I_D	8	-7	
	T_A = 70 °C		6	-6	
Pulsed Drain Current[1]		I_{DM}	32	-28	
Avalanche Current		I_{AS}	22	-30	
Avalanche Energy	L = 0.1mH	EAS	24.2	45	mJ
Repetitive Avalanche Energy[2]	L = 0.05mH	EAR	12.1	22.50	
Power Dissipation	T_C = 25 °C	P_D	5	5	W
	T_C = 100 °C		2	2	
Power Dissipation	T_A = 25 °C	P_D	2	2	W
	T_A = 70 °C		1.3	1.3	
Operating Junction & Storage Temperature Range		T_j, T_{stg}	-55 to 150		°C

▪THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM		UNIT
			N-CH	P-CH	
Junction-to-Case	$R_{\theta JC}$		25	25	°C/W
Junction-to-Ambient[3]	$R_{\theta JA}$		62.5	62.5	

[1]Pulse width limited by maximum junction temperature.
[2]Duty cycle < 1%
[3]62.5°C / W when mounted on a 1 in^2 pad of 2 oz copper.
[4]Guarantee by Engineering test

▪ **N-CH_ELECTRICAL CHARACTERISTICS (T_J = 25 °C, Unless Otherwise Noted)**

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage[4]	$V_{(BR)DSS}$	V_{GS} = 0V, I_D = 250uA	30			V
Gate Threshold Voltage[4]	$V_{GS(th)}$	V_{DS} = V_{GS}, I_D = 250uA	1.5	1.8	3	
Gate-Body Leakage[4]	I_{GSS}	V_{DS} = 0V, V_{GS} = ±20V			±100	nA
Zero Gate Voltage Drain Current[4]	I_{DSS}	V_{DS} = 24V, V_{GS} = 0V			1	uA
		V_{DS} =20V, V_{GS} = 0V, T_J = 125 °C			25	
On-State Drain Current[1]	$I_{D(ON)}$	V_{DS} = 10V, V_{GS} = 10V	12			A
Drain-Source On-State Resistance[1,4]	$R_{DS(ON)}$	V_{GS} = 10V, I_D = 10A		15	18	mΩ
		V_{GS} = 4.5V, I_D = 6A		21	26	
DYNAMIC						
Input Capacitance[5]	C_{iss}	V_{GS} = 0V, V_{DS} = 15V, f = 1MHz		727		pF
Output Capacitance[5]	C_{oss}			123		
Reverse Transfer Capacitance[5]	C_{rss}			107		
Gate Resistance[4,5]	R_g	f = 1MHz		1.4		Ω
Total Gate Charge[1,2,5]	Q_g(V_{GS}=10V)	V_{DS} = 15V, V_{GS} = 10V, I_D = 10A		16.0		nC
	Q_g(V_{GS}=4.5V)			8.8		
Gate-Source Charge[1,2,5]	Q_{gs}			2.0		
Gate-Drain Charge[1,2,5]	Q_{gd}			4.8		
Turn-On Delay Time[1,2,5]	$t_{d(on)}$	V_{DS} = 15V, V_{GS} = 10V, I_D = 5A , Rg = 6Ω		6.7		nS
Rise Time[1,2,5]	t_r			12.2		
Turn-Off Delay Time[1,2,5]	$t_{d(off)}$			21.4		
Fall Time[1,2,5]	t_f			16.2		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS						
Continuous Current	I_S				12	A
Pulsed Current[3]	I_{SM}				32	
Forward Voltage[1,4]	V_{SD}	I_F = 15A, V_{GS} = 0V			1.2	V
Reverse Recovery Time[5]	t_{rr}	I_F = 15A, dI_F/dt = 100A / uS		10.3		nS
Reverse Recovery Charge[5]	Q_{rr}			4.3		nC

[1]Pulse test : Pulse Width ≦ 300 usec, Duty Cycle ≦ 2%.

[2]Independent of operating temperature.

[3]Pulse width limited by maximum junction temperature.

[4]Guarantee by FT test Item

[5]Guarantee by Engineering test

EMC will review datasheet by quarter, and update new version.

▪TYPICAL CHARACTERISTICS

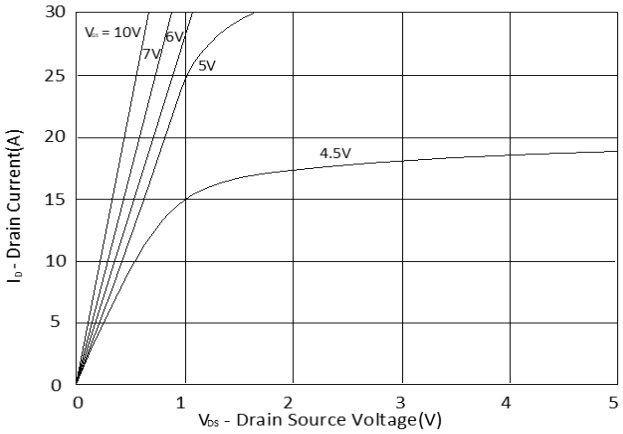


Fig.1 Typical Output Characteristics

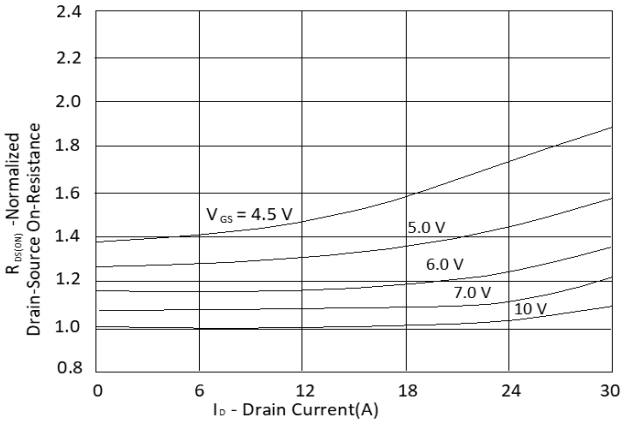


Fig.2 On-Resistance Variation with Drain Current and Gate Voltage

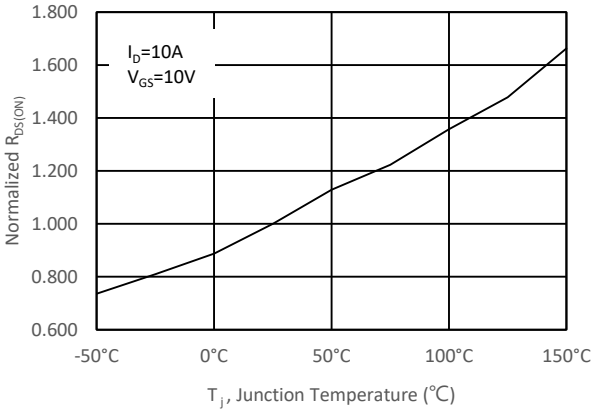


Fig.3 Normalized On-Resistance v.s. Junction Temperature

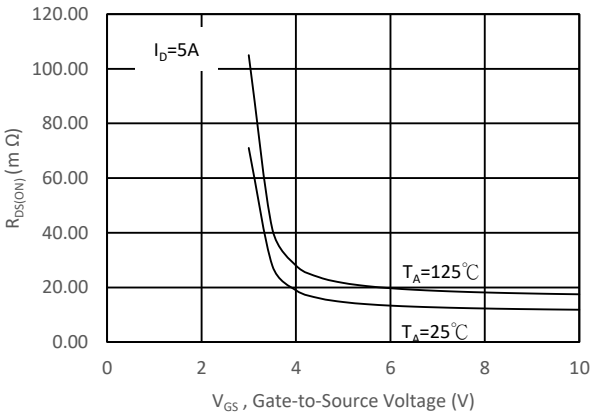


Fig.4 On-Resistance v.s. Gate Voltage

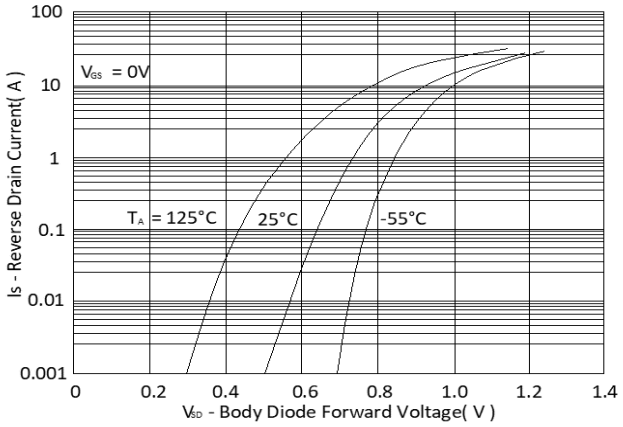


Fig.5 Forward Characteristic of Reverse Diode

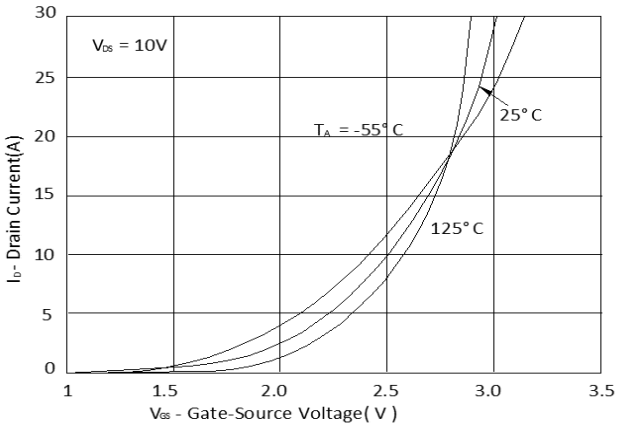


Fig.6 Transfer Characteristics

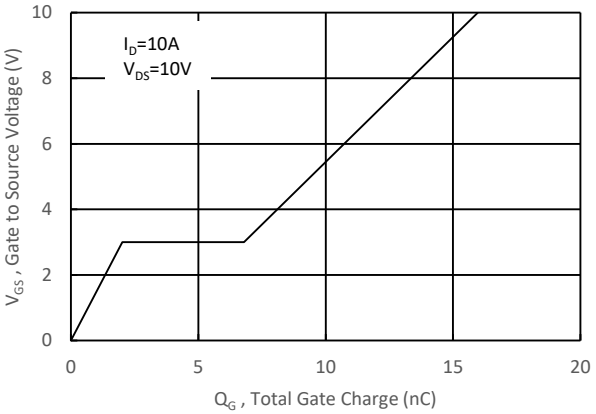


Fig.7 Gate Charge Characteristics

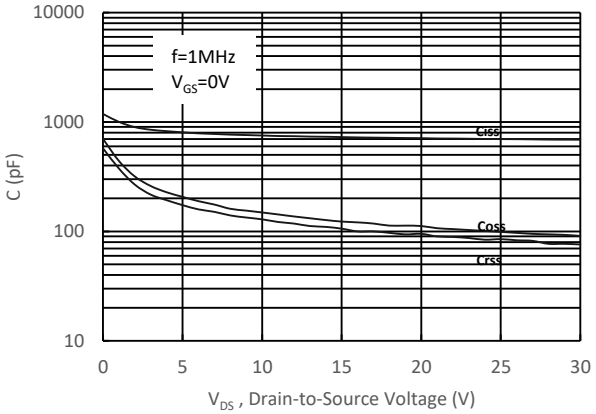


Fig.8 Typical Capacitance Characteristics

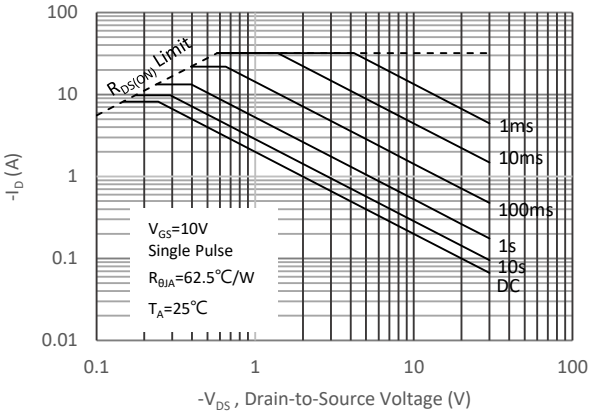


Fig 9. Maximum Safe Operating Area

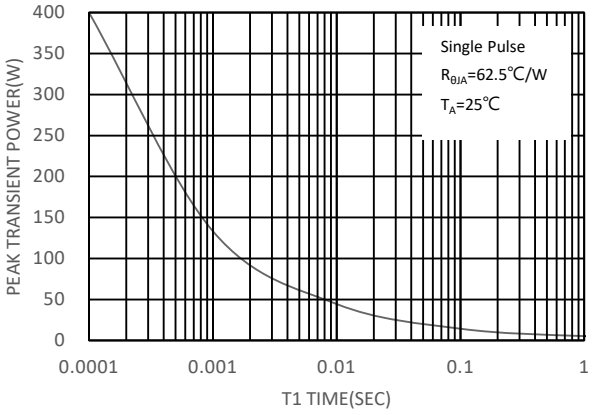


Fig 10. Single Pulse Maximum Power Dissipation

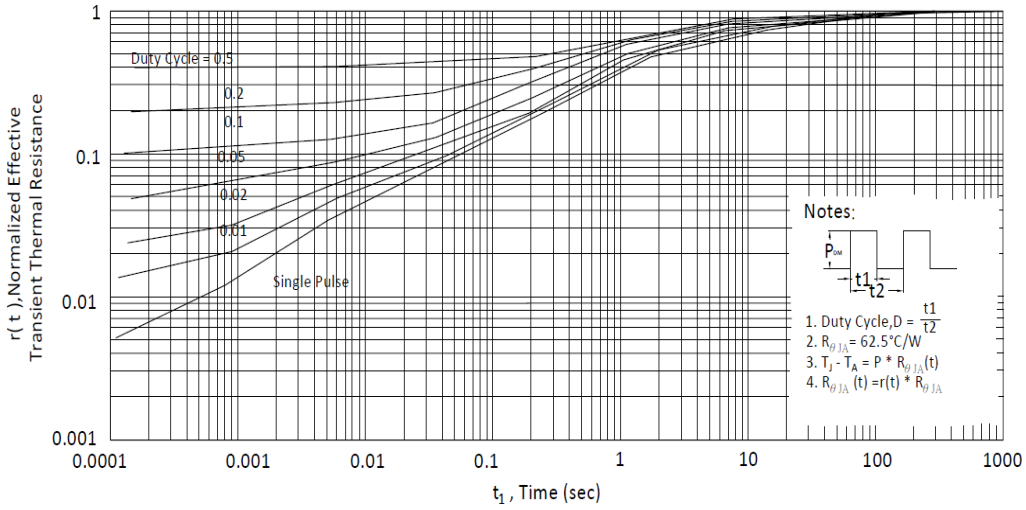


Fig 11. Effective Transient Thermal Impedance

▪ **P-CH_ELECTRICAL CHARACTERISTICS (T_J = 25 °C, Unless Otherwise Noted)**

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage[4]	$V_{(BR)DSS}$	V_{GS} = 0V, I_D = -250uA	-30			V
Gate Threshold Voltage[4]	$V_{GS(th)}$	V_{DS} = V_{GS}, I_D = -250uA	-1.5	-2.0	-3.0	
Gate-Body Leakage[4]	I_{GSS}	V_{DS} = 0V, V_{GS} = ±20V			±100	nA
Zero Gate Voltage Drain Current[4]	I_{DSS}	V_{DS} = -24V, V_{GS} = 0V			-1	uA
		V_{DS} =-20V, V_{GS} =0V, T_J = 125 °C			-25	
On-State Drain Current[1]	$I_{D(ON)}$	V_{DS} = -5V, V_{GS} = -10V	-12			A
Drain-Source On-State Resistance[1,4]	$R_{DS(ON)}$	V_{GS} = -10V, I_D = -8A		18	22	mΩ
		V_{GS} = -4.5V, I_D = -6A		28	37	
DYNAMIC						
Input Capacitance[5]	C_{iss}	V_{GS} = 0V, V_{DS} = -15V, f = 1MHz		775		pF
Output Capacitance[5]	C_{oss}			126		
Reverse Transfer Capacitance[5]	C_{rss}			100		
Gate Resistance[4,5]	R_g	f = 1MHz		5.2		Ω
Total Gate Charge[1,2,5]	Q_g(V_{GS}=10V)	V_{DS} = -15V, V_{GS} = -10V, I_D = -8A		14.6		nC
	Q_g(V_{GS}=4.5V)			7.8		
Gate-Source Charge[1,2,5]	Q_{gs}			2.3		
Gate-Drain Charge[1,2,5]	Q_{gd}			3.8		
Turn-On Delay Time[1,2,5]	$t_{d(on)}$	V_{DS} = -15V, V_{GS} = -10V, I_D = -5A , Rg = 6Ω		6.5		nS
Rise Time[1,2,5]	t_r			14.0		
Turn-Off Delay Time[1,2,5]	$t_{d(off)}$			27.9		
Fall Time[1,2,5]	t_f			24.5		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS						
Continuous Current	I_S				-12	A
Pulsed Current[3]	I_{SM}				-28	
Forward Voltage[1,4]	V_{SD}	I_F = -15A, V_{GS} = 0V			-1.2	V
Reverse Recovery Time[5]	t_{rr}	I_F = -15A, dI_F/dt = 100A / uS		6.7		nS
Reverse Recovery Charge[5]	Q_{rr}			2.4		nC

[1]Pulse test : Pulse Width ≦ 300 usec, Duty Cycle ≦ 2%.

[2]Independent of operating temperature.

[3]Pulse width limited by maximum junction temperature.

[4]Guarantee by FT test Item

[5]Guarantee by Engineering test

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▪TYPICAL CHARACTERISTICS

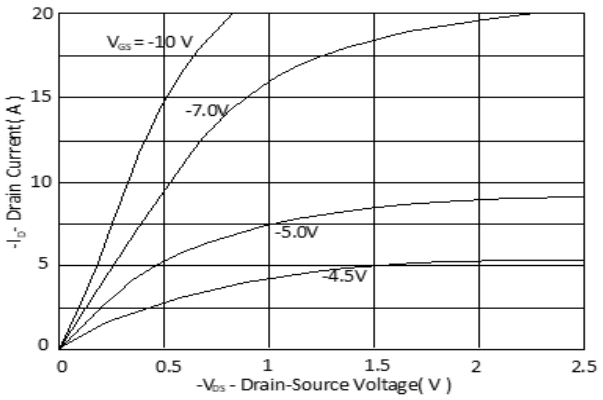


Fig.1 Typical Output Characteristics

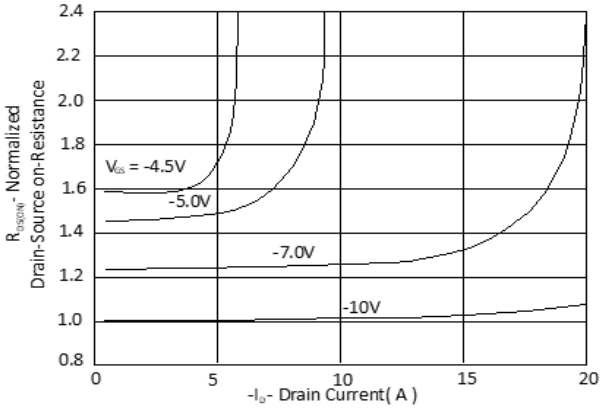


Fig.2 On-Resistance Variation with Drain Current and Gate Voltage

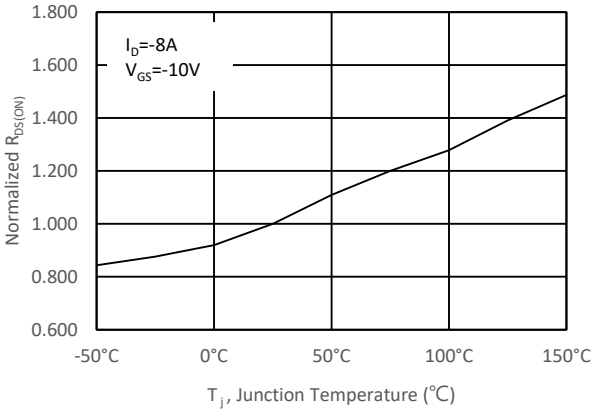


Fig.3 Normalized On-Resistance v.s. Junction Temperature

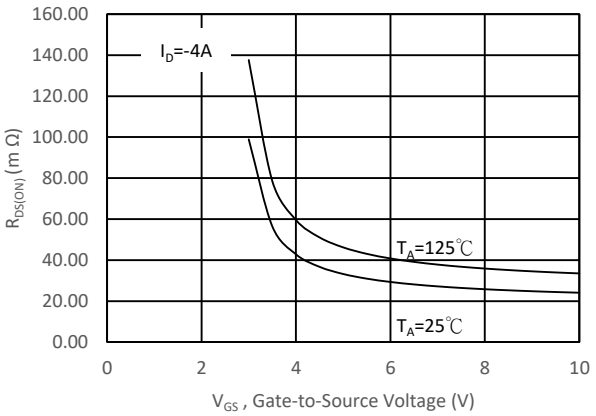


Fig.4 On-Resistance v.s. Gate Voltage

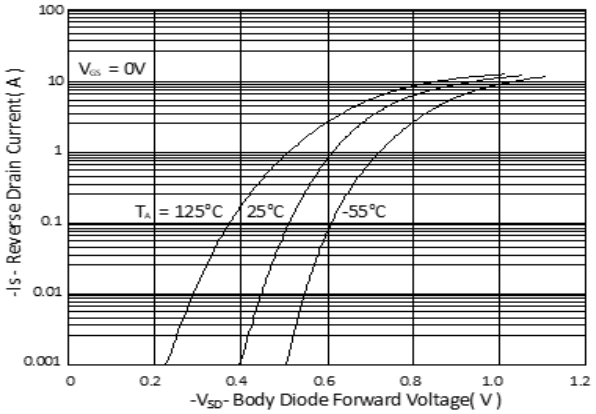


Fig.5 Forward Characteristic of Reverse Diode

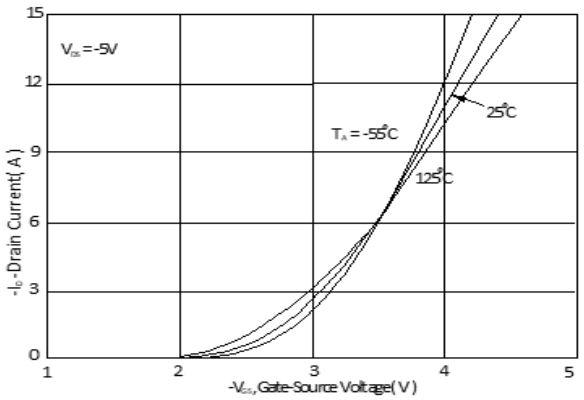


Fig.6 Transfer Characteristics

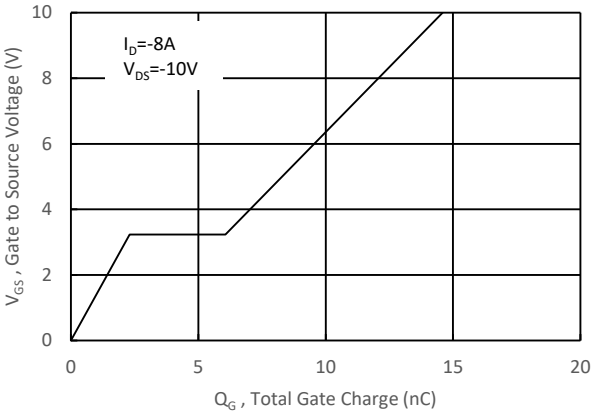


Fig.7 Gate Charge Characteristics

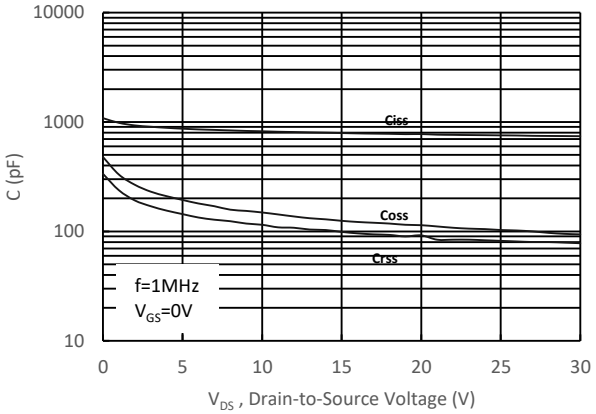


Fig.8 Typical Capacitance Characteristics

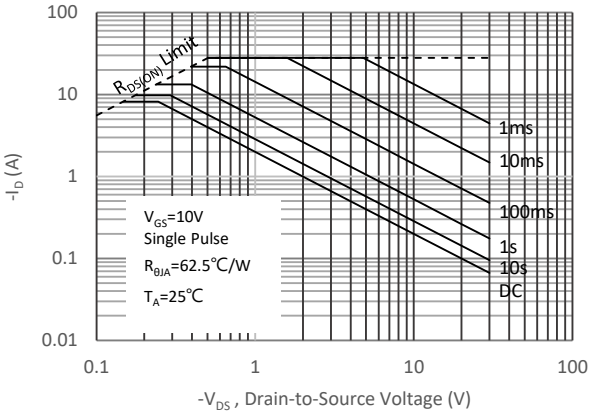


Fig 9. Maximum Safe Operating Area

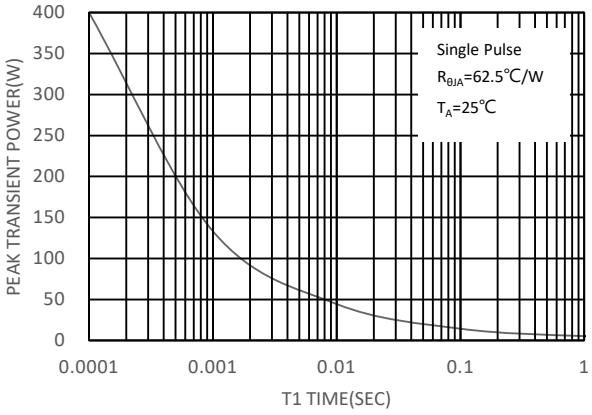


Fig 10. Single Pulse Maximum Power Dissipation

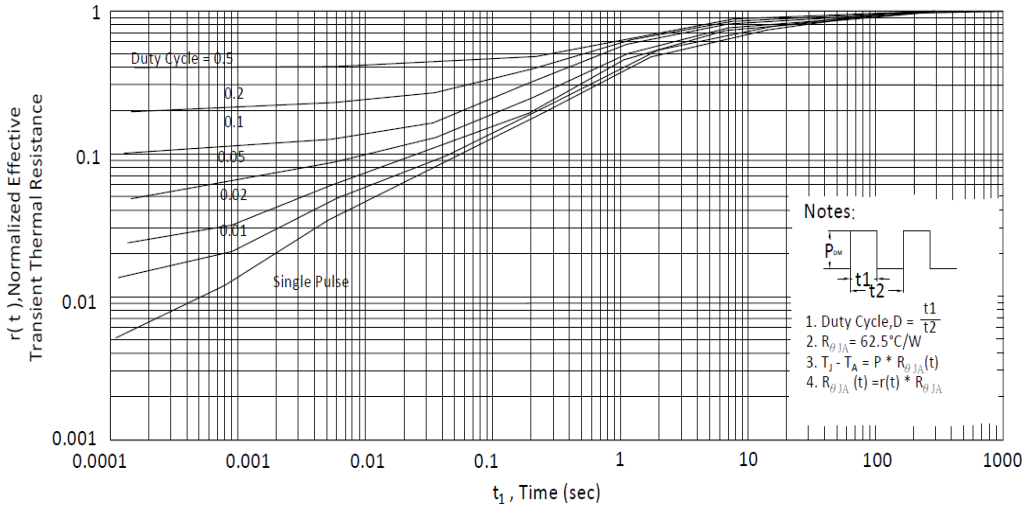
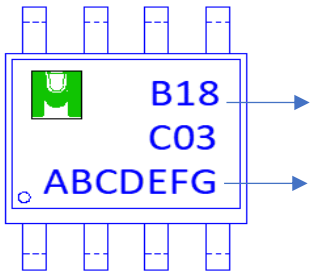


Fig 11. Effective Transient Thermal Impedance

Ordering & Marking Information:

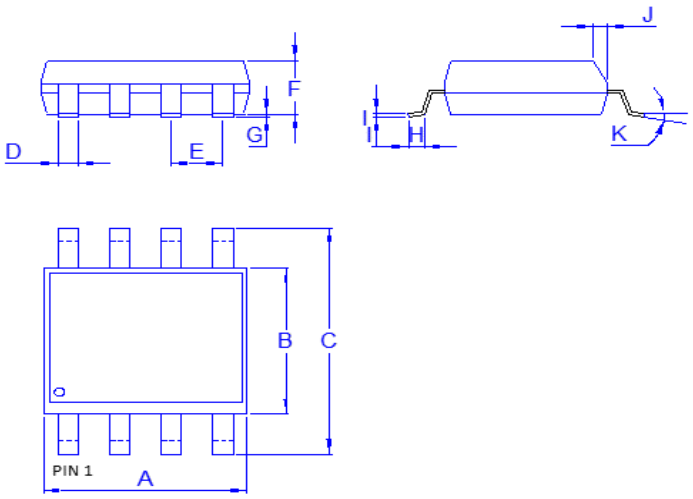
Device Name: EMB18C03G for SOP-8



B18C03: Device Name

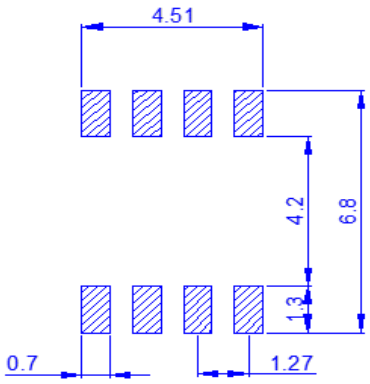
ABCDEFG: Date Code
A: Assembly House
B: Year(A:2008 B:2009 C:2010….)
C: Month(A:01 B:02 C:03 D:04 E:05 F:06 G:07 H:08 I:09 J:10 K:11 L:12)
DEFG: Serial No.

Outline Drawing

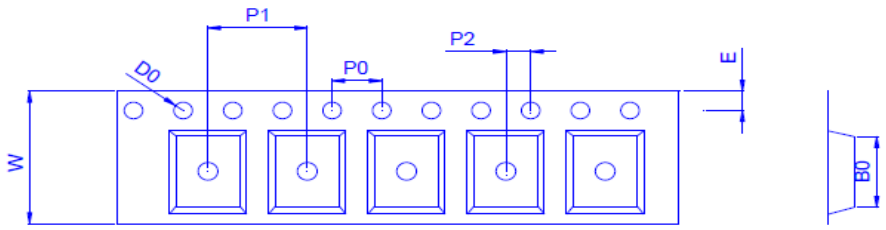


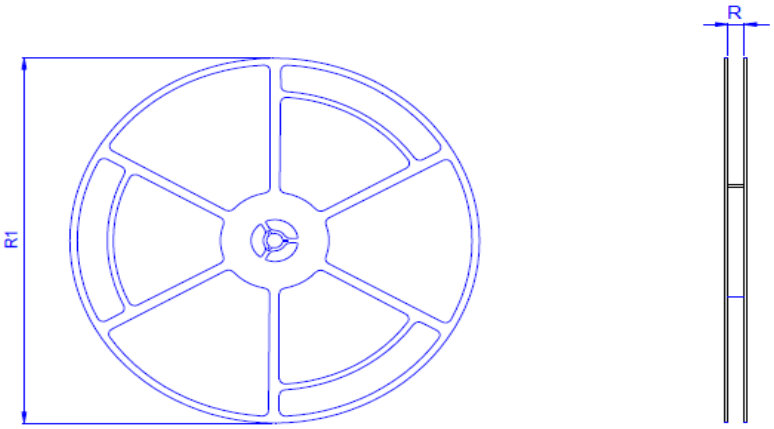
Dimension	A	B	C	D	E	F	G	H	I	J	K
Min.	4.7	3.8	5.8	0.31		1.35	0.01	0.4	0.1	0.25	0°
Typ.	4.9	3.9	6	0.41	1.27	1.55	0.18	0.6	0.2	0.3	
Max.	5.1	4	6.2	0.51		1.75	0.25	1.27	0.25	0.5	8°

Footprint



◆ **Tape&Reel Information:2500pcs/Reel**





產品別	(P)SOP-8
Reel 尺寸	13”
編帶方式	FEED DIRECTION

Dimension in mm

Dimension	Carrier tape							Reel	
	B0	D0	E	P0	P1	P2	W	R	R1
Typ.	6.50	1.50	1.75	4.00	8.00	2.00	12.00	12.40	330.00
±	0.40	0.20	0.20	0.20	0.20	0.20	0.50	REF	REF